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# **A Statistical Test Suite for Random and Pseudorandom Number Generators for Cryptographic Applications**

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Andrew Rukhin, Juan Soto, James Nechvatal, Miles Smid, Elaine Barker, Stefan Leigh, Mark Levenson, Mark Vangel, David Banks, Alan Heckert, James Dray, San Vo

Revised: April 2010  
Lawrence E Bassham III



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